

<b>Notice of References Cited</b>	Application/Control No. 09/989,975	Applicant(s)/Patent Under Reexamination ABE ET AL.	
	Examiner David J. Steadman	Art Unit 1652	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	94/01567	01-1994	WO	Klis et al.	-----
	O	99/60152	11-1999	WO	Makarow	-----
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Heo et al. (2003) FEMS Yeast Res 4:175-184, <i>abstract only</i>
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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